PROCEEDINGS OF SPIE

Photonic Instrumentation Engineering XI

Lynda E. Busse Yakov Soskind Editors

29–31 January 2024 San Francisco, California, United States

Sponsored and Published by SPIE

Volume 12893

Proceedings of SPIE 0277-786X, V. 12893

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

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Please use the following format to cite material from these proceedings: Author(s), "Title of Paper," in *Photonic Instrumentation Engineering XI*, edited by Lynda E. Busse, Yakov Soskind, Proc. of SPIE 12893, Seven-digit Article CID Number (DD/MM/YYYY); (DOI URL).

ISSN: 0277-786X

ISSN: 1996-756X (electronic)

ISBN: 9781510670464

ISBN: 9781510670471 (electronic)

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA Telephone +1 360 676 3290 (Pacific Time)

SPIE.org

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